# CIS 371 Computer Organization and Design

Unit 12: Reliability

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#### **DRAM Error Detection**

- Idea: add extra state to DRAM to detect a bit flip
- Parity: simplest scheme
  - · One extra bit, detects any single bit flip
  - Parity bit = XOR(data<sub>N-1</sub>, ..., data<sub>1</sub>, data<sub>0</sub>)
- Example:
  - 010101 0^1^0^1^0^1 = "1" so parity is "odd" (versus "even")
  - So, store "010101 1" in memory
  - When you read the data, and re-calculate the parity, say
    - 011101 1, if the parity bit doesn't match, error detected
- Multiple bit errors? more redundancy can detect more

Reliability of Logic and Memory

- As transistors get smaller, they are less reliable
  - Wasn't a problem a few years ago, becoming a big problem
- Transient faults
  - A bit "flips" randomly, temporarily
  - Cosmic rays and such (more common at higher altitudes!)
  - Memory cells (especially DRAM) vulnerable today, logic soon
- Permanent (hard) faults
  - · A gate or memory cell wears out
  - · Breaks and stays broken
- Solution for both: use **redundancy** to detect and tolerate CIS 371 (Martin/Roth): Reliability 2

#### **DRAM Error Detection**

- What to do on a parity error?
- Crash
  - Dead programs tell no lies
  - Fail-stop is better than silent data corruption
  - Avoiding writing that "\$1m check"
- For user-level data, OS can kill just the program
  - Not the whole system, unless it was OS data
- Alternative: correct the error

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## SEC Error Correction Code (ECC)

- SEC: single-error correct (a hamming code)
- Example: Four data bits, three "code" bits
  - $d_1 d_2 d_3 d_4 c_1 c_2 c_3 \rightarrow c_1 c_2 d_1 c_3 d_2 d_3 d_4$
  - $c_1 = d_1 \wedge d_2 \wedge d_4$ ,  $c_2 = d_1 \wedge d_3 \wedge d_4$ ,  $c_3 = d_2 \wedge d_3 \wedge d_4$
  - Syndrome:  $c_i \wedge c'_i = 0$ ? no error : points to flipped-bit
- Working example
  - Original data =  $0110 \rightarrow c_1 = 1$ ,  $c_2 = 1$ ,  $c_3 = 0$
  - Flip  $d_2 = 0010 \rightarrow c'_1 = 0$ ,  $c'_2 = 1$ ,  $c'_3 = 1$ 
    - Syndrome = 101 (binary 5) → 5th bit? D<sub>2</sub>
  - Flip  $c_2 \rightarrow c'_1 = 1$ ,  $c'_2 = 0$ ,  $c'_3 = 0$ 
    - Syndrome = 010 (binary 2)  $\rightarrow$  2nd bit?  $c_2$

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#### Disk Reliability: RAID

- Error correction: more important for disk than for memory
  - Error correction/detection per block (handled by disk hardware)
  - Mechanical disk failures (entire disk lost) most common failure mode
    - · Many disks means high failure rates
    - Entire file system can be lost
- RAID (redundant array of inexpensive disks)
  - · Add redundancy
  - Similar to DRAM error correction, but...
  - Major difference: which disk failed is known
    - Even parity can be used to recover from single failures
    - Parity disk can be used to reconstruct data faulty disk
  - RAID design balances bandwidth and fault-tolerance
  - Implemented in hardware (faster, more expensive) or software

#### SECDED Error Correction Code (ECC)

- **SECDED**: single error correct, double error detect
- Example:  $D = 4 \rightarrow C = 4$ 
  - $d_1 d_2 d_3 d_4 c_1 c_2 c_3 \rightarrow c_1 c_2 d_1 c_3 d_2 d_3 d_4 c_4$
  - $c_4 = c_1 ^ c_2 ^ d_1 ^ c_3 ^ d_2 ^ d_3 ^ d_4$
  - Syndrome == 0 and  $c'_4 == c_4 \rightarrow$  no error
  - Syndrome != 0 and  $c'_4$ !=  $c_4 \rightarrow 1$ -bit error
  - Syndrome != 0 and  $c'_4 == c_4 \rightarrow 2$ -bit error
  - Syndrome == 0 and  $c'_4 != c_4 \rightarrow c_4$  error
  - In general: C = log<sub>2</sub>D + 2
- Many machines today use 64-bit SECDED code
  - C = 8 (64bits + 8bits = 72bits, 12% overhead)
  - ChipKill correct any aligned 4-bit error
    - If an entire DRAM chips dies, the system still works!

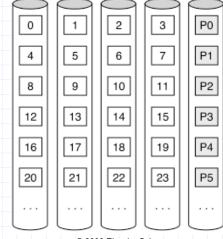
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# Simple Disk Array with Bit-level Parity

#### Bit-level parity

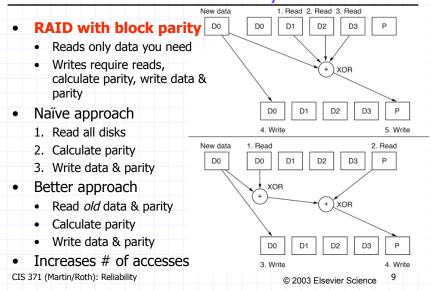
- dedicated parity disk
- N+1 disks, calculate parity (write all, read all)
- Good sequential read/write bandwidth, poor random accesses
- If N=8, only 13% overhead



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# **RAID** with Block-level Parity



# Aside: Storage Backup

- Data is more valuable than hardware!
  - Almost always true
- Protecting data three aspects
  - User error accidental deletion
    - Aside: ".snapshot" on enaic-l/halfdome filesystem
  - **Disk failure** mechanical, wears out over time
    - Disk arrays (RAID) works well
  - **Disaster recovery** An entire site is disabled
- Two approaches:
  - Frequent tape backups, taken off site (most common today)
  - Handle each problem distinctly
    - File system, redundant disks, network-based remote backup

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## **RAID** with Block-level Parity

• Rotates the parity disk, avoid single-disk bottleneck

